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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE  
(213.003-D1-US)

In re Application of: **Ye et al.**

) Group Art Unit:

Serial No: **10/677,563**

) Examiner:

Filed: **January 13, 2004**

)

Title: **Method and Apparatus for Monitoring  
Integrated Circuit Fabrication**

)

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

I hereby certify that this correspondence is  
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Date

Neil Steinberg  
(person signing this certificate)

  
Signature

**SECOND INFORMATION DISCLOSURE STATEMENT**

Dear Sir:

Submitted herewith is one (1) sheet of a modified Form PTO-1449. All of the documents listed on the modified Form PTO-1449 were provided or cited in the parent application of the above-captioned application. Accordingly, the documents are not enclosed herewith. (See 37 C.F.R. §1.98(d) and MPEP 609). Should the Examiner desire an additional copy of the documents, kindly contact the undersigned.

It is respectfully requested that the Examiner make his/her consideration of these references formally of record with the initial Office Action.

Respectfully submitted,

  
Neil A. Steinberg  
Reg. No. 34,735  
650-968-8079

Date: May 21, 2004

MAY 24 2004

Sheet 1 of 9

 U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.	SERIAL NUMBER
	213.003-D1-US	10/756,718
	APPLICANT(S) Ye et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	FILING DATE January 13, 2004	GROUP ART UNIT 2825

## U. S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	5,907,820	5/1999	Pan			
	5,967,661	10/1999	Renken et al.			
	6,033,922	3/2000	Rowland et al.			
	6,051,443	4/2000	Ghio et al.			
	6,244,121	6/2001	Hunter			
	6,630,995	10/2003	Hunter			
	6,693,708	2/2004	Hunter			
	6,707,545	3/2004	Hunter			
	6,721,045	4/2004	Hunter			

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER	DATE CONSIDERED
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EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.